

UPDATED 11/12/2007

14.40-15.35GHz 8-Watt Internally-Matched Power FET

FEATURES

- 14.40-15.35GHz Bandwidth
- Input/Output Impedance Matched to 50 Ohms
- +39.5 dBm Output Power at 1dB Compression
- 6.5 dB Power Gain at 1dB Compression
- 27% Power Added Efficiency
- 100% Tested for DC, RF, and R_{TH}



ELECTRICAL CHARACTERISTICS (T_a = 25°C)



Caution! ESD sensitive device.

SYMBOL	PARAMETERS/TEST CONDITIONS ¹	MIN	TYP	MAX	UNITS
P _{1dB}	Output Power at 1dB Compression $f = 14.40-15.35GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 2200\text{mA}$	38.5	39.5		dBm
G _{1dB}	Gain at 1dB Compression $f = 14.40-15.35GHz$ $V_{DS} = 10 \text{ V}, I_{DSQ} \approx 2200\text{mA}$	5.5	6.5		dB
ΔG	Gain Flatness f = 14.40-15.35GHz V_{DS} = 10 V, I_{DSQ} ≈ 2200mA			±0.6	dB
PAE	Power Added Efficiency at 1dB Compression $V_{DS} = 10 \text{ V}$, $I_{DSQ} \approx 2200\text{mA}$ f = 14.40-15.35GHz		27		%
Id _{1dB}	Drain Current at 1dB Compression f =14.40-15.35GHz		2800	3600	mA
I _{DSS}	Saturated Drain Current $V_{DS} = 3 \text{ V}, V_{GS} = 0 \text{ V}$		4200	5760	mA
V_P	Pinch-off Voltage $V_{DS} = 3 \text{ V}, I_{DS} = 40 \text{ mA}$		-1.2	-2.5	٧
R _{TH}	Thermal Resistance ³		3.5	4.0	°C/W

Note: 1. Tested with 100 Ohm gate resistor.

2. S.C.L. = Single Carrier Level.

ABSOLUTE MAXIMUM RATING FOR EFE

SYMBOLS	PARAMETERS	ABSOLUTE ¹	CONTINUOUS ²	
Vds	Drain-Source Voltage	15V	10V	
Vgs	Gate-Source Voltage	-5V	-4V	
lgf	Forward Gate Current	96.0mA	28.8mA	
lgr	Reverse Gate Current	-19.2mA	-4.8mA	
Pin	Input Power	38.5dBm	@ 3dB Compression	
Tch	Channel Temperature	175C	175C	
Tstg	Storage Temperature	-65C to +175C	-65C to +175C	
Pt	Pt Total Power Dissipation 37.5W		37.5W	

Note: 1. Exceeding any of the above ratings may result in permanent damage.

^{3.} Overall Rth depends on case mounting.

^{2.} Exceeding any of the above ratings may reduce MTTF below design goals.

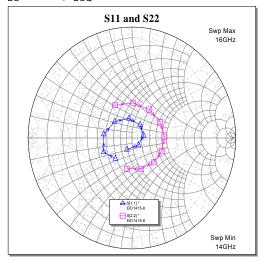


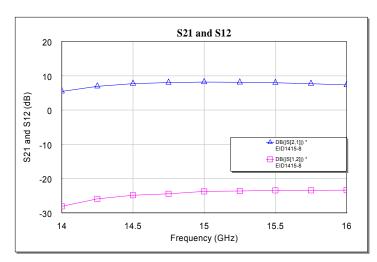
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PERFORMANCE DATA

Typical S-Parameters (T= 25°C, 50Ω system, de-embedded to edge of package) V_{DS} = 10 V, I_{DSQ} ≈ 2200mA





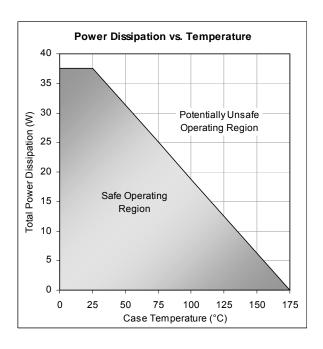
FREQ	S	S11		S21		S12		S22	
(GHz)	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG	
14.00	0.2450	-130.30	1.8778	115.29	0.0393	99.39	0.3370	118.62	
14.20	0.2992	-148.84	2.1685	100.98	0.0463	85.54	0.3201	94.18	
14.40	0.2904	-173.75	2.3778	82.93	0.0540	66.32	0.3111	68.35	
14.60	0.2558	159.14	2.4914	64.05	0.0582	47.41	0.3062	43.95	
14.80	0.2117	130.18	2.5593	45.58	0.0635	26.31	0.3090	22.47	
15.00	0.1773	98.99	2.5706	27.10	0.0649	8.39	0.3143	2.10	
15.20	0.1484	65.63	2.5618	8.94	0.0656	-11.68	0.3119	-17.31	
15.40	0.1225	30.44	2.5022	-9.51	0.0675	-31.59	0.3086	-36.12	
15.60	0.1012	-7.86	2.4780	-27.74	0.0667	-50.84	0.2987	-55.37	
15.80	0.0906	-59.05	2.4084	-46.06	0.0671	-69.19	0.2882	-76.98	
16.00	0.1147	-115.00	2.3324	-64.47	0.0677	-88.41	0.2827	-99.97	



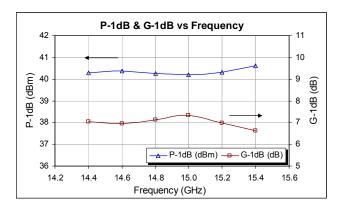
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Power De-rating Curve



Typical Power Data ($V_{DS} = 10 \text{ V}$, $I_{DSQ} = 2200 \text{ mA}$)



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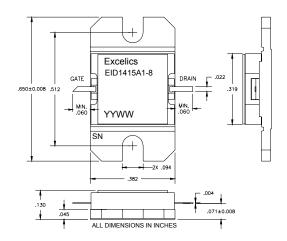
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PACKAGES OUTLINE

Dimensions in inches, Tolerance + .005 unless otherwise specified

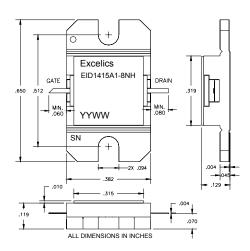
EID1415A1-8 (Hermetic)





Caution! ESD sensitive device.

EID1415A1-8NH (Non-Hermetic)





Caution! ESD sensitive device.

ORDERING INFORMATION

Part Number	Packages	Grade ¹	f _{Test} (GHz)	P _{1dB} (min)
EID1415A1-8	Hermetic	Industrial	14.40-15.35GHz	38.5
EID1415A1-8NH	Non-Hermetic	Industrial	14.40-15.35GHz	38.5

Notes:

- 1. Contact factory for military and hi-rel grades.
- 2. Exact test conditions are specified in "Electrical Characteristics" table.

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